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*Call for Participation*

**26<sup>th</sup> North Atlantic Test Workshop**  
**May 8-10, 2017**  
**Providence, Rhode Island**

Sponsored by the  
**IEEE Providence Section**

<http://natw.ieee.org>

The IEEE North Atlantic Test Workshop (NATW) provides a forum for discussions on the latest issues relating to high quality, economical, and efficient test methodologies and designs. In addition to the traditional topics, the 2017 edition of NATW will feature the theme of vehicle electronics.

Highlights of the NATW 2017 program:

- Monday Tutorial

*“System Level Validation of SoCs: Power and Performance Testing With Use Cases”*

**Al Czamara**, Test Evolution, US

- Monday Invited talk:

*“Edge Computing and Contextual Information for the Internet of Things Sensors”*

**Levente Klein**, IBM, US

- Monday Panel on *“Automobile Reliability”*

Organizers: **Eugene Atwood**, IBM, US and **Malinky Ghosh**, GlobalFoundries, US

- Tuesday Keynote talk:

*“Breaking New Ground: Testing Challenges for Autonomy and Robotics”*

**Justin Ray**, Edge Case Research, US

- Tuesday afternoon is reserved for a trip to Battleship Cove, the world’s largest exhibit of historic naval ships and maritime museum. For more details about Battleship Cove please visit <http://battleshipcove.org>.

- Wednesday Invited talk: *“Securing Physically Unclonable Functions”*

**Sandip Kundu**, University of Massachusetts at Amherst, US

- To encourage student participation in the testing research community, NATW has sessions dedicated to student presentations and includes a Best Student Paper Award. Student papers include talks from University of Massachusetts at Amherst, Southern Illinois University, University of Vermont, Brown University and Southern Methodist University.

To take advantage of the early registration discounts, please register before April 24 online at <http://www.cvent.com/d/65q0c2>.

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